TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

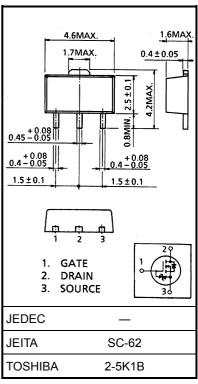
2SK2992

Chopper Regulator, DC-DC Converter and Motor Drive Applications

- Low drain-source ON resistance : RDS (ON) = 2.2 Ω (typ.)
- High forward transfer admittance $|Y_{fs}| = 0.9 \text{ S (typ.)}$ •
- Low leakage current $: I_{DSS} = 100 \ \mu A \ (max) \ (V_{DS} = 200 \ V)$ •
- Enhancement-mode $: V_{th} = 2.0 \sim 3.5 \text{ V} (V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	200	V	
Drain-gate voltage (R	_{GS} = 20 kΩ)	V _{DGR}	200	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	Ι _D	1	А	
	Pulse (Note 1)	I _{DP}	3	А	
Drain power dissipation	1	PD	0.5	W	
Drain power dissipation	n (Note 2)	PD	1.5	W	
Single pulse avalanche	e energy (Note 3)	E _{AS}	36	mJ	
Avalanche current		I _{AR}	1	А	
Repetitive avalanche e	nergy (Note 4)	E _{AR}	0.05	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature ra	inge	T _{stg}	-55~150	°C	



Weight: 0.05 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit	
Thermal resistance, channel to ambient	R _{th (ch−a)}	250	°C/W	

Note 1: Please use devices on condition that the channel temperature is below 150°C.

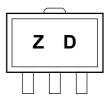
Note 2: Mounted on ceramic substrate (25.4 mm × 25.4 mm × 0.8 mm)

Note 3: V_{DD} = 50 V, T_{ch} = 25°C (initial), L = 56.7 mH, R_G = 25 Ω , I_{AR} = 1 A

Note 4: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution.

Marking



⁽The two digits represent the part number.)

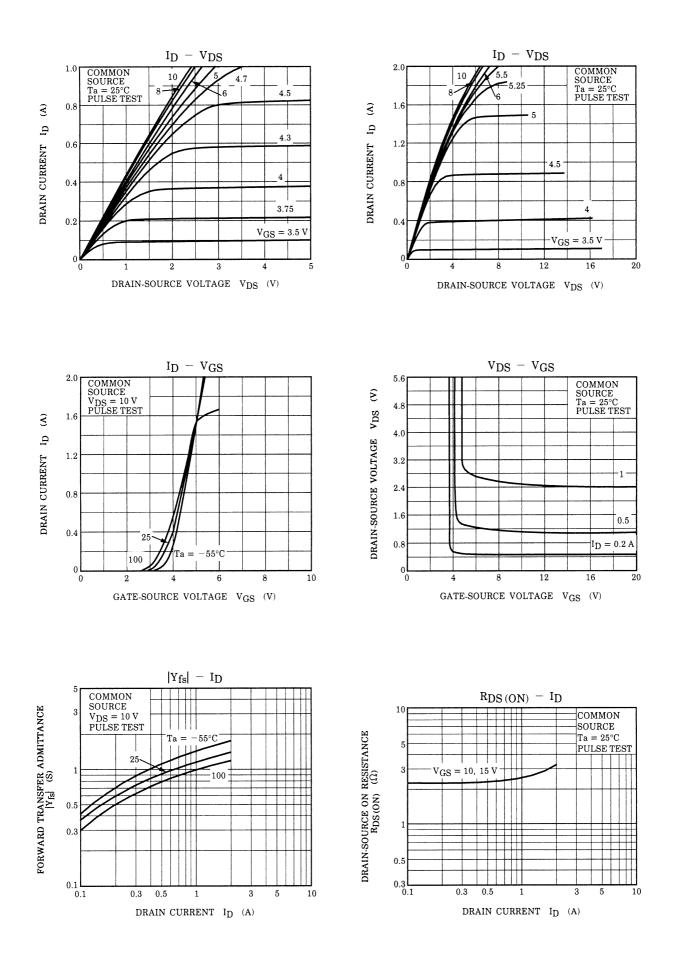
Unit: mm

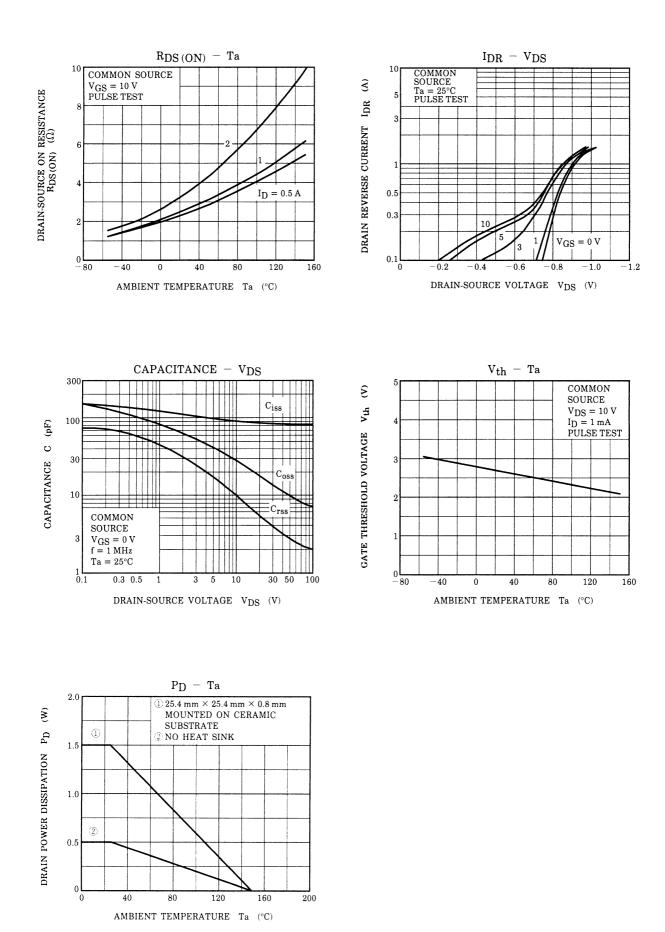
Electrical Characteristics (Ta = 25°C)

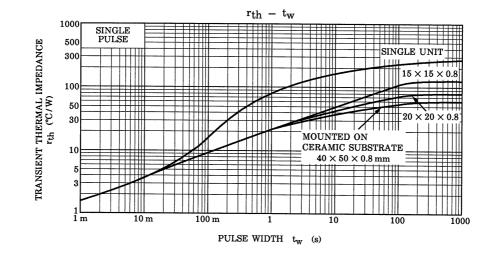
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V		_	±10	μA
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 200 V, V _{GS} = 0 V	_		100	μA
Drain−source br voltage	eakdown	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	200	_	_	V
Gate threshold v	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	3.5	V
Drain-source O	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 0.5 A	—	2.2	3.5	Ω
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 0.5 A	0.5	0.9		S
Input capacitance	e	C _{iss}			90	_	
Reverse transfe	erse transfer capacitance C_{rss} V_{DS} = 10 V, V_{GS} = 0 V, f = 1 MHz		_	10	_	pF	
Output capacitance		C _{oss}			30		_
Switching time	Rise time	tr	$V_{GS} \stackrel{10V}{_{0V}} \int I_{D} = 0.5A \\ V_{GS} \stackrel{V_{OUT}}{_{0V}} \int I_{D} = 0.5A \\ V_{OUT} \stackrel{V_{OUT}}{_{1}} \\ V_{DD} = 100V$	_	9	_	
	Turn-on time	t _{on}		_	17	_	
	Fall time	t _f		_	16	_	ns
	Turn-off time	t _{off}	Duty $\leq 1\%$, t _w =10µs	_	45	_	
Total gate charge (gate-source plus gate-drain)		Qg		_	3.0	_	
Gate-source charge		Q _{gs}	V _{DD} ≈ 160 V, V _{GS} = 10 V, I _D = 1 A		1.8	_	nC
Gate-drain ("miller") Charge		Q _{gd}			1.2	_	

Source–Drain Ratings and Characteristics (Ta = 25°C)

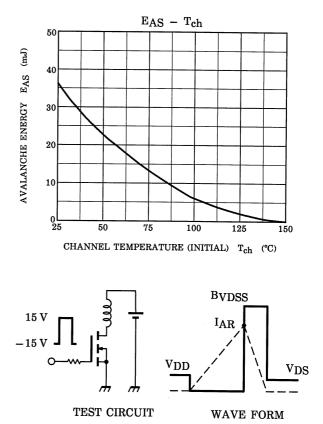
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—	_	_	1	А
Pulse drain reverse current (Note 1)	I _{DRP}	—	_	_	3	А
Forward voltage (diode)	V _{DSF}	I _{DR} = 1 A, V _{GS} = 0 V	_	_	-1.5	V
Reverse recovery time	t _{rr}	I _{DR} = 1 A, V _{GS} = 0 V, dI _{DR} / dt = 100 A / μs	_	85	—	ns
Reverse recovery charge	Q _{rr}		_	190	_	nC







SAFE OPERATING AREA 10 Ħ 5 ID MAX. (PULSE) 💥 3 1 msЖ 1 Ð 0.5 10 msЖ 0.3 DRAIN CURRENT ID ID MAX. (CONTINUOUS) 0.1 0.05 DC OPERATION 0.03 Ta = 25°C Ш 0.01 **※ SINGLE NONREPETITIVE** 0.005 PULSE Ta = 25°C 0.003 Curves must be derated linearly with increase in temperature. VDSS MAX. 0.001 0.1 0.3 1 3 10 30 100 300 DRAIN-SOURCE VOLTAGE V_{DS} (V)



$$\begin{array}{l} \mathrm{R_{G}=25\ \Omega} \\ \mathrm{V_{DD}=50\ V,\ L=56.7\ mH} \end{array} \quad \mathbf{E_{AS}=\frac{1}{2}\cdot L\cdot I^{2}\cdot \left(\frac{\mathrm{B_{VDSS}}}{\mathrm{B_{VDSS}-V_{DD}}}\right) \end{array}$$

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